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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of:

DAVID R. HEMBREE
WARREN M. FARNWORTH
SALMAN AKRAM
ALAN G. WOOD
C. PATRICK DOHERTY
ANDREW J. KRIVY

Serial No.:

Art Unit:

Division of Serial No. 09/929,388
filed August 14, 2001

Examiner

Filing Date: February 5, 2002

For: METHOD FOR TESTING
SEMICONDUCTOR WAFERS (AS AMENDED)

Attorney Docket No. 96-750.3

**PRELIMINARY AMENDMENT
SUBMITTED WITH CONTINUING APPLICATION
UNDER 37 CFR 1.53(b)**

February 5, 2002

Assistant Commissioner of Patents
BOX PATENT APPLICATION
Washington, D.C. 20231

Sir:

This Preliminary Amendment is being filed with a divisional application under 37 CFR 1.53(b). Please amend the captioned case as follows.

In the Drawings

Please substitute the attached new formal drawings for the drawings originally filed in parent application serial no. 08/797,719. The new formal drawings are also being submitted separately to the Official Draftsperson by "Transmittal Letter To The Official Draftsperson".